


<b>Search Notes</b>  	<b>Application/Control No.</b>  10525374	<b>Applicant(s)/Patent Under Reexamination</b>  ETOU ET AL.
	<b>Examiner</b>  Burney, Rachel L	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner
430	110.1	08/20/2007	RLB//

SEARCH NOTES		
Search Notes	Date	Examiner
Inventorship search	08/20/2007	/RLB/
Consulted with SPE Mark Huff	08/20/2007	/RLB/
Text Search in EAST (see search history print out)	08/20/2007	/RLB/
Updated text search in EAST (see search history)	04/28/2008	/RLB/
Updated text search in EAST (see search history)	09/22/2008	/RLB/
Updated text search in EAST (see search history)	03/02/2009	/RLB/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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Examiner, Art Unit 1795